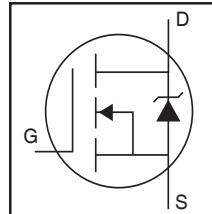


# IRFR4510PbF

# IRFU4510PbF

## Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

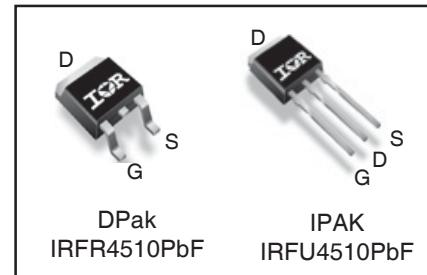


HEXFET® Power MOSFET

<b>V<sub>DSS</sub></b>	<b>100V</b>
<b>R<sub>DS(on)</sub></b>	<b>typ.</b> <b>11.1mΩ</b>
	<b>max.</b> <b>13.9mΩ</b>
<b>I<sub>D</sub> (Silicon Limited)</b>	<b>63A</b>
<b>I<sub>D</sub> (Package Limited)</b>	<b>56A</b>

## Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



G	D	S
Gate	Drain	Source

## Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	63	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	45	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	56	
I <sub>DM</sub>	Pulsed Drain Current ①	252	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Maximum Power Dissipation	143	W
	Linear Derating Factor	0.95	W/C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

## Avalanche Characteristics

E <sub>AS</sub> (Thermally limited)	Single Pulse Avalanche Energy ②	127	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①		mJ

## Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case ③	—	1.05	°C/W
R <sub>θJA</sub>	Junction-to-Ambient (PCB Mount) ⑦	—	50	
R <sub>θJA</sub>	Junction-to-Ambient	—	110	

## ORDERING INFORMATION:

See detailed ordering and shipping information on the last page of this data sheet.

Notes ① through ⑧ are on page 11

[www.irf.com](http://www.irf.com)

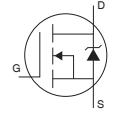
**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

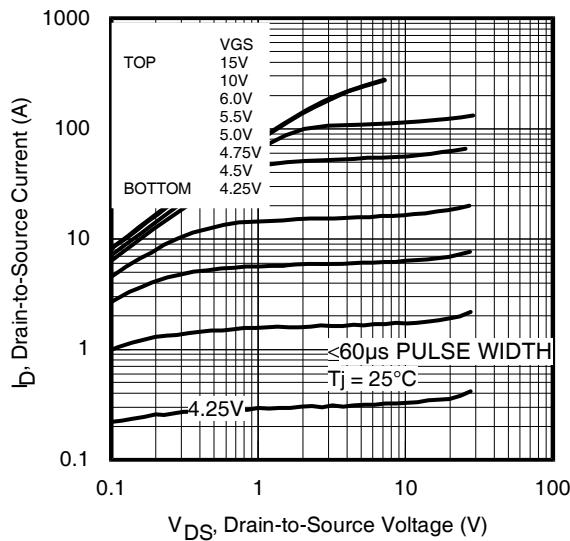
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.10	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 5\text{mA}$ $\textcircled{1}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	11.1	13.9	$\text{m}\Omega$	$V_{GS} = 10V, I_D = 38\text{A}$ $\textcircled{4}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	3.0	4.0	V	$V_{DS} = V_{GS}, I_D = 100\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{DS} = 100V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 100V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
$R_{G(\text{int})}$	Internal Gate Resistance	—	0.61	—	$\Omega$	

**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

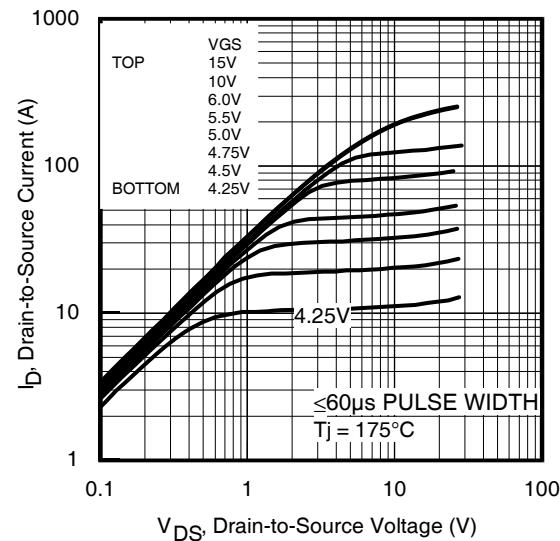
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{fs}$	Forward Transconductance	62	—	—	S	$V_{DS} = 25V, I_D = 38\text{A}$
$Q_g$	Total Gate Charge	—	54	81	nC	$I_D = 38\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	14	—		$V_{DS} = 50V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	15	—		$V_{GS} = 10V$ $\textcircled{4}$
$Q_{\text{sync}}$	Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )	—	39	—		$I_D = 38\text{A}, V_{DS} = 0V, V_{GS} = 10V$
$t_{d(on)}$	Turn-On Delay Time	—	18	—	ns	$V_{DD} = 65V$
$t_r$	Rise Time	—	42	—		$I_D = 38\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	42	—		$R_G = 7.5\Omega$
$t_f$	Fall Time	—	34	—		$V_{GS} = 10V$ $\textcircled{4}$
$C_{iss}$	Input Capacitance	—	3031	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	213	—		$V_{DS} = 50V$
$C_{rss}$	Reverse Transfer Capacitance	—	104	—		$f = 1.0\text{MHz}$
$C_{oss \text{ eff. (ER)}}$	Effective Output Capacitance (Energy Related)	—	255	—		$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ $\textcircled{6}$
$C_{oss \text{ eff. (TR)}}$	Effective Output Capacitance (Time Related)	—	478	—		$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ $\textcircled{5}$

**Diode Characteristics**

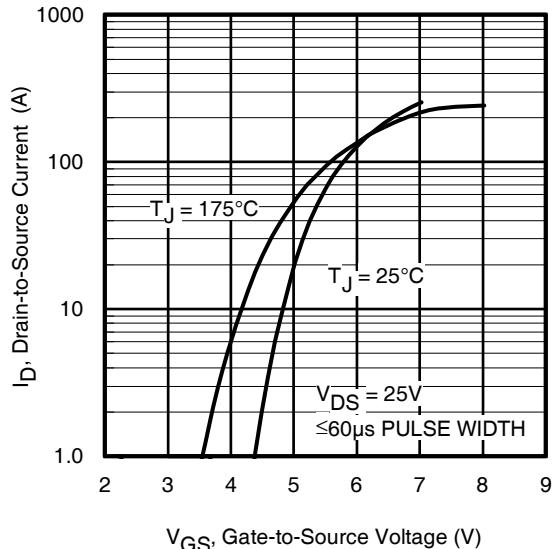
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current (Body Diode)	—	—	56	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) $\textcircled{1}$	—	—	252		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 38\text{A}, V_{GS} = 0V$ $\textcircled{4}$
$dv/dt$	Peak Diode Recovery	—	7.0	—	V/ns	$T_J = 175^\circ\text{C}, I_S = 38\text{A}, V_{DS} = 100V$ $\textcircled{3}$
$t_{rr}$	Reverse Recovery Time	—	34	—	ns	$T_J = 25^\circ\text{C}$ $V_R = 86V$
		—	39	—		$T_J = 125^\circ\text{C}$ $I_F = 38A$
$Q_{rr}$	Reverse Recovery Charge	—	47	—	nC	$T_J = 25^\circ\text{C}$ $di/dt = 100A/\mu\text{s}$ $\textcircled{4}$
		—	61	—		$T_J = 125^\circ\text{C}$
$I_{RRM}$	Reverse Recovery Current	—	2.4	—	A	$T_J = 25^\circ\text{C}$
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				



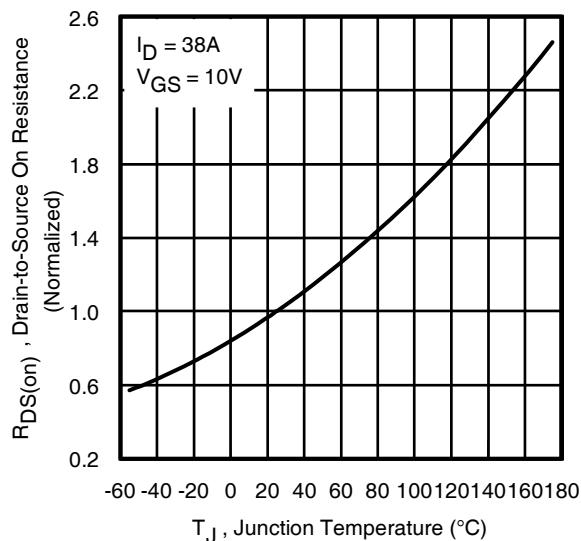
**Fig 1.** Typical Output Characteristics



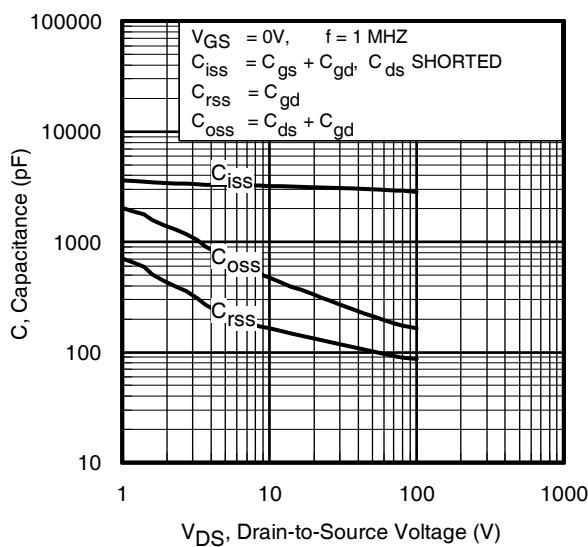
**Fig 2.** Typical Output Characteristics



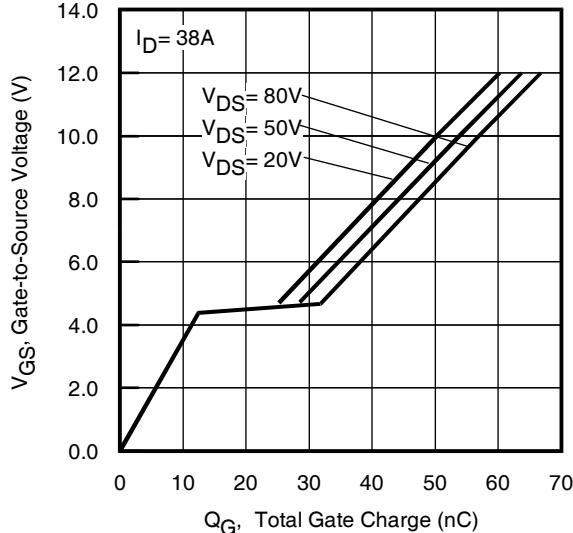
**Fig 3.** Typical Transfer Characteristics



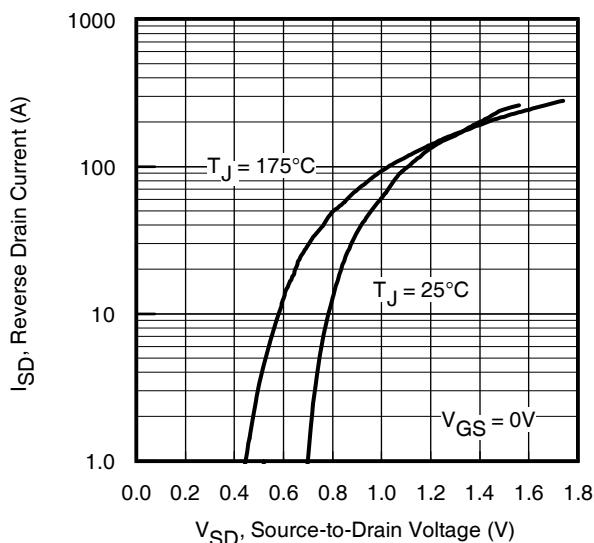
**Fig 4.** Normalized On-Resistance vs. Temperature



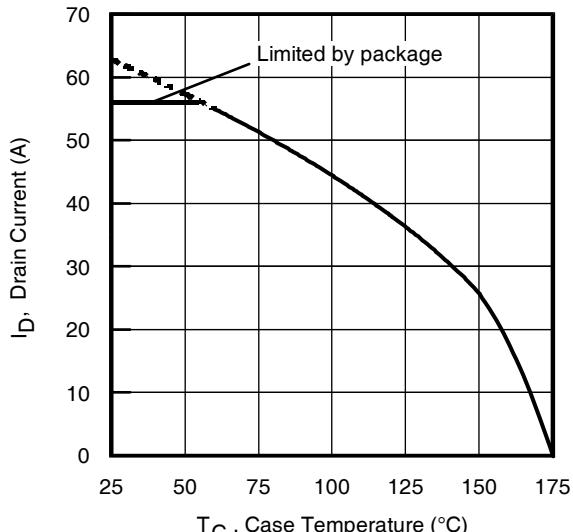
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



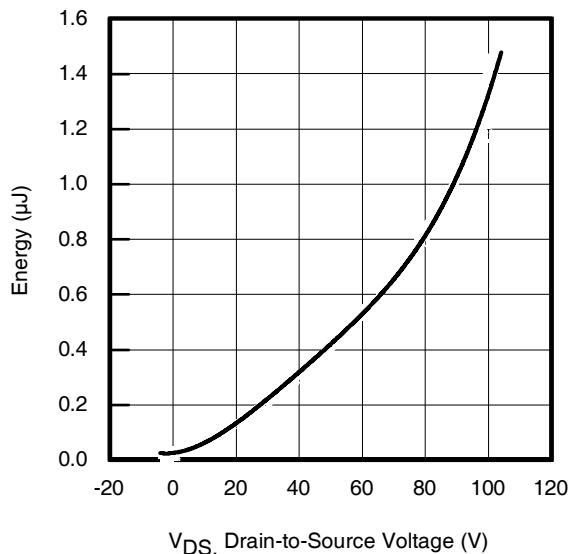
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage



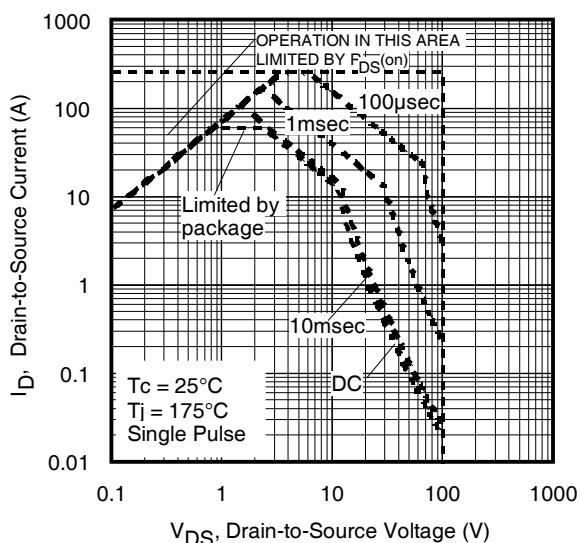
**Fig 7.** Typical Source-Drain Diode Forward Voltage



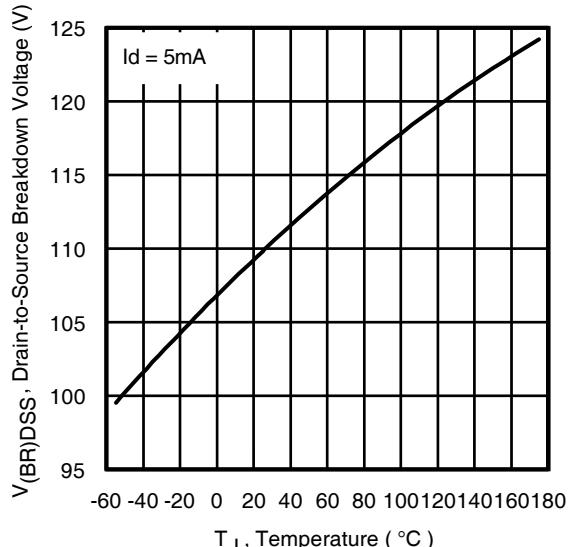
**Fig 9.** Maximum Drain Current vs. Case Temperature



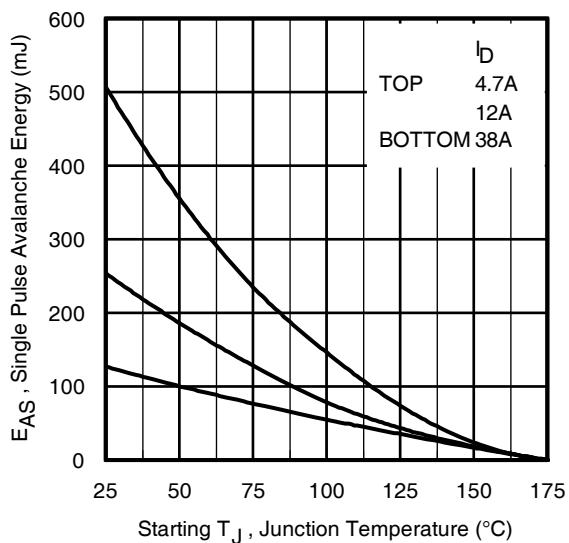
**Fig 11.** Typical Coss Stored Energy



**Fig 8.** Maximum Safe Operating Area



**Fig 10.** Drain-to-Source Breakdown Voltage



**Fig 12.** Maximum Avalanche Energy vs. Drain Current

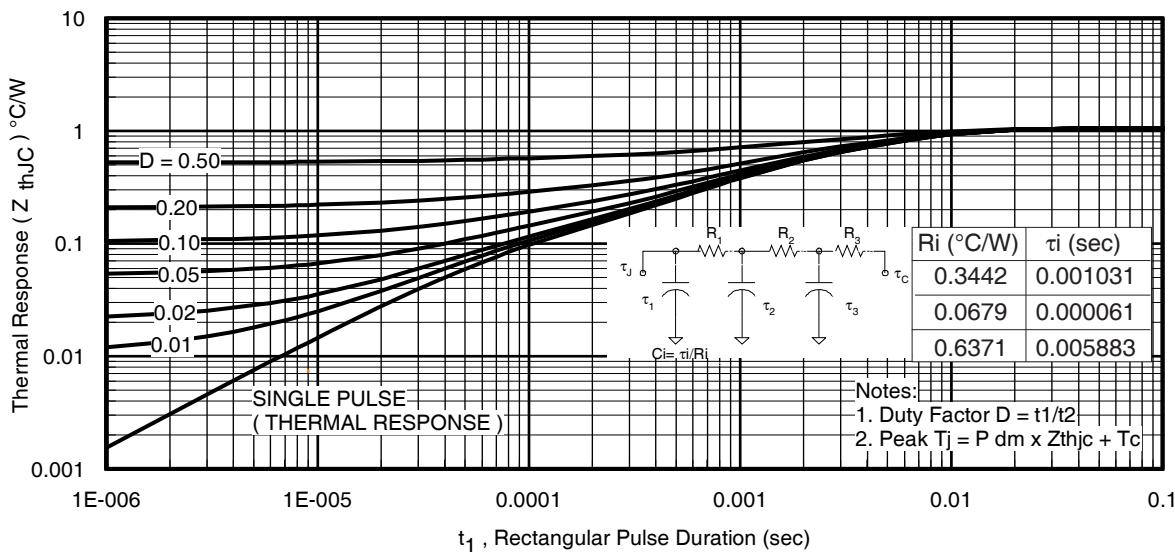


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

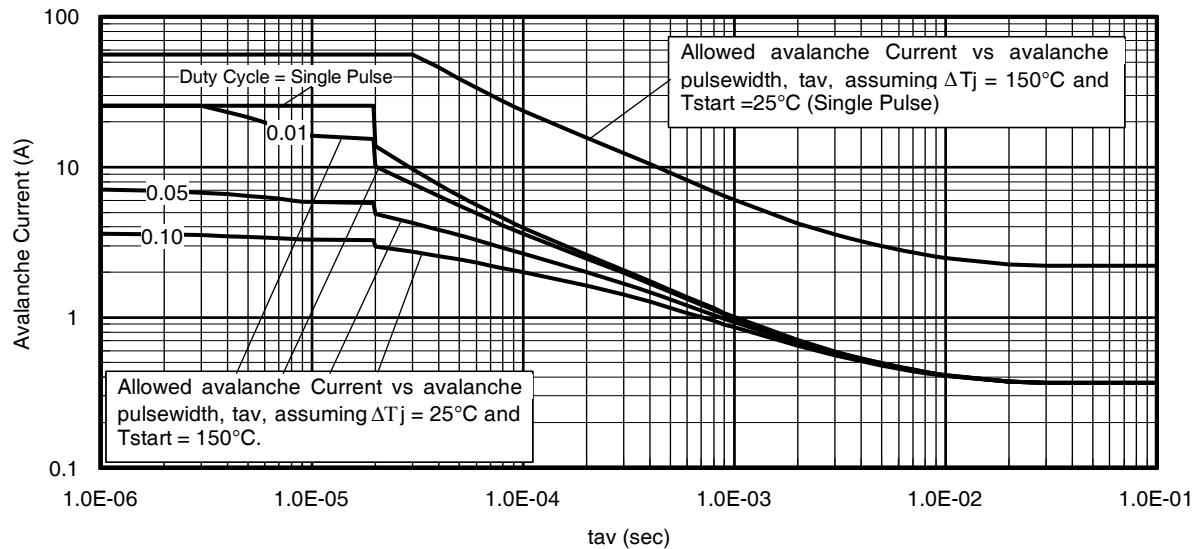
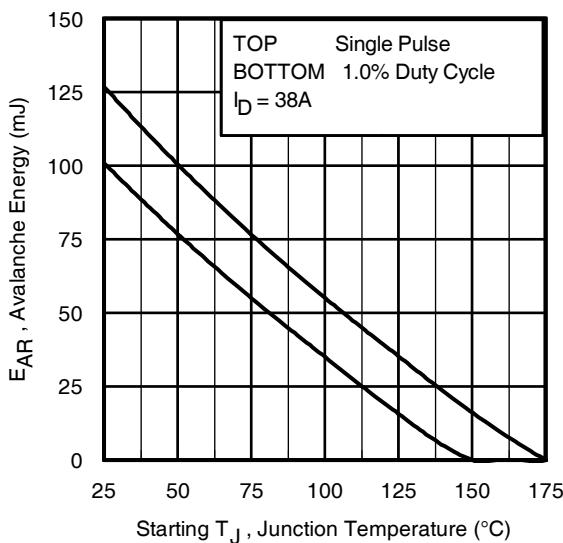


Fig 14. Typical Avalanche Current vs.Pulsewidth



Notes on Repetitive Avalanche Curves , Figures 14, 15:  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

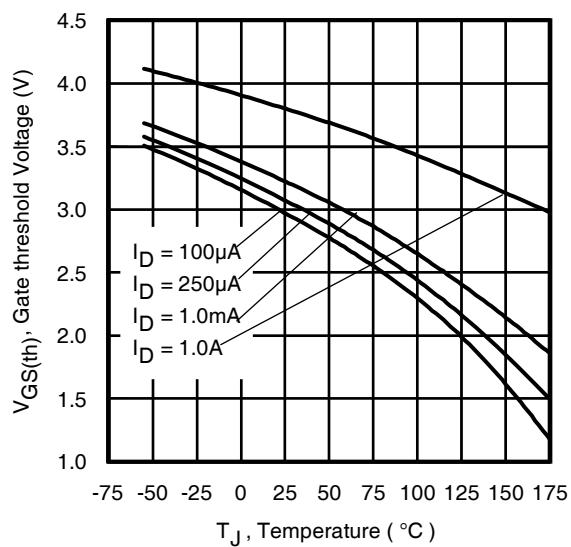
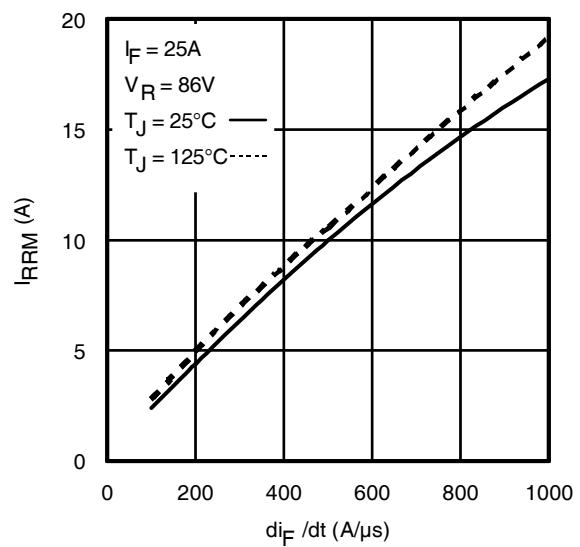
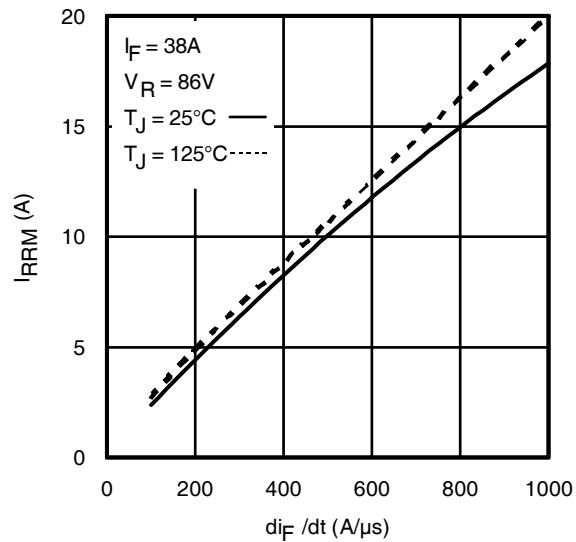
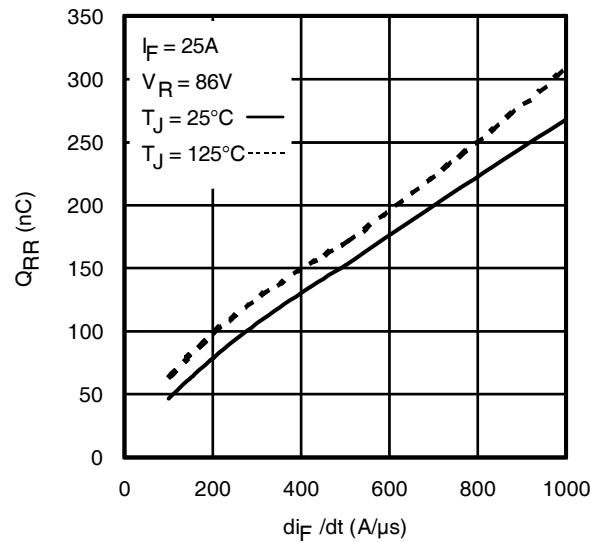
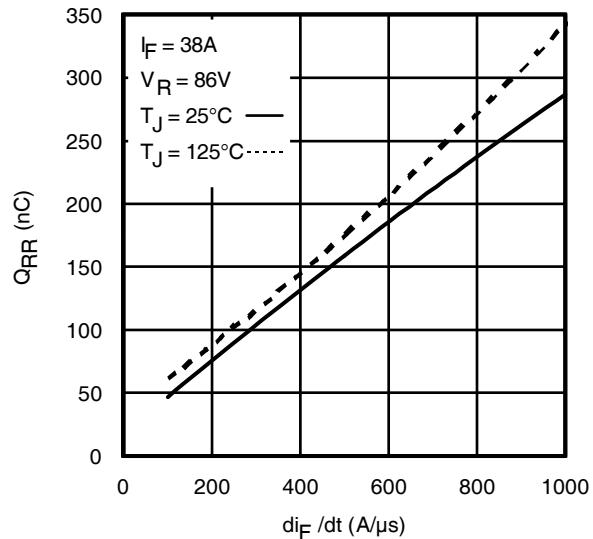
1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^{\circ}\text{C}$  in Figure 14, 15).
- $t_{av}$  = Average time in avalanche.
- $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$
- $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13

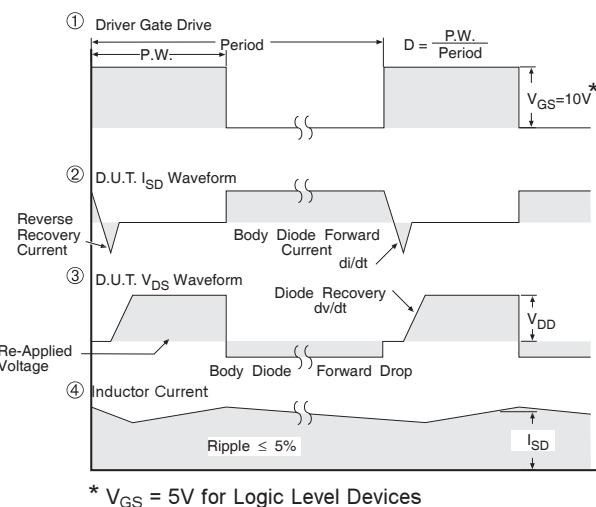
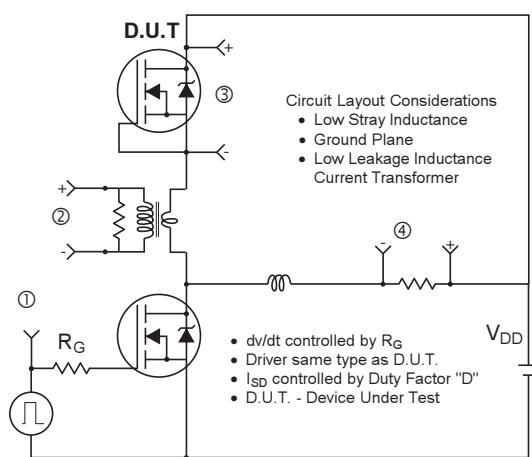
$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

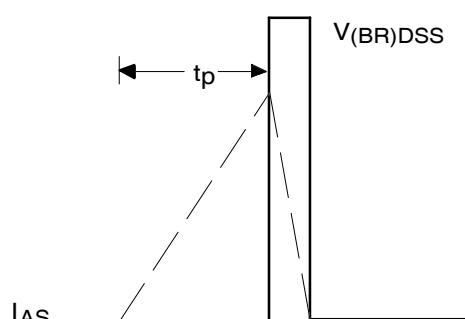
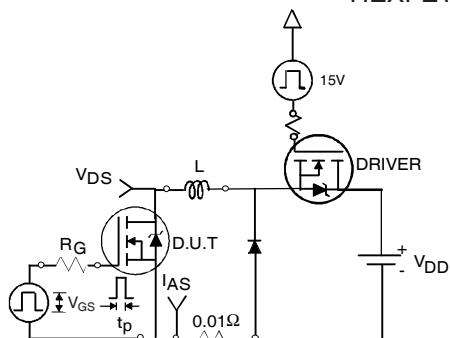
$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

Fig 15. Maximum Avalanche Energy vs. Temperature

**Fig. 16.** Threshold Voltage vs. Temperature**Fig. 17 -** Typical Recovery Current vs.  $di_f/dt$ **Fig. 18 -** Typical Recovery Current vs.  $di_f/dt$ **Fig. 19 -** Typical Stored Charge vs.  $di_f/dt$ **Fig. 20 -** Typical Stored Charge vs.  $di_f/dt$

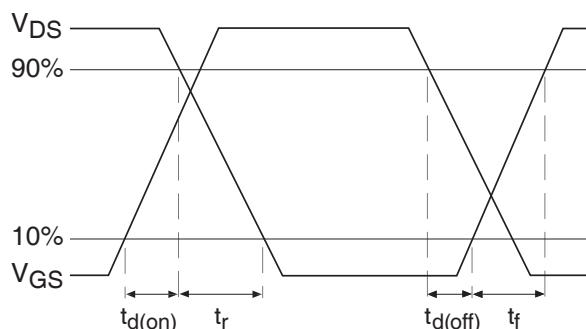
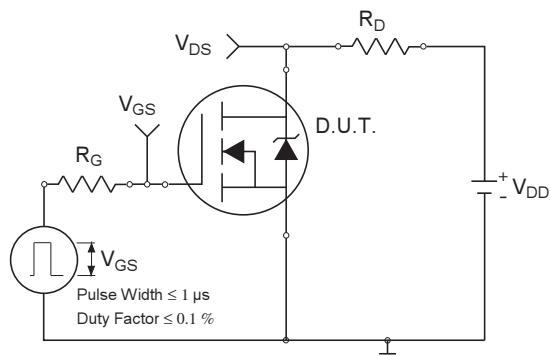


**Fig 21.** Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs



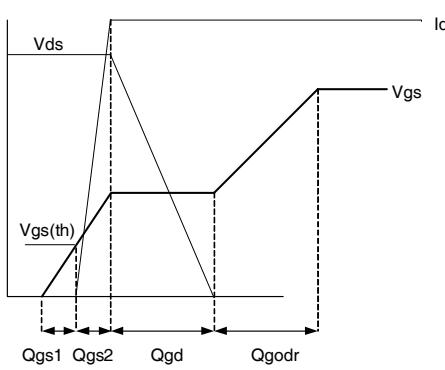
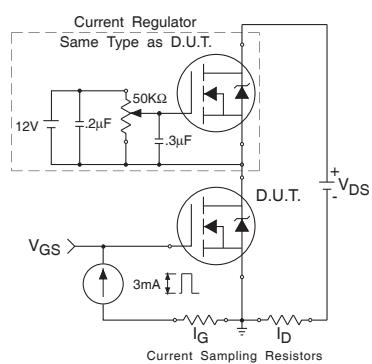
**Fig 22a.** Unclamped Inductive Test Circuit

**Fig 22b.** Unclamped Inductive Waveforms



**Fig 23a.** Switching Time Test Circuit

**Fig 23b.** Switching Time Waveforms

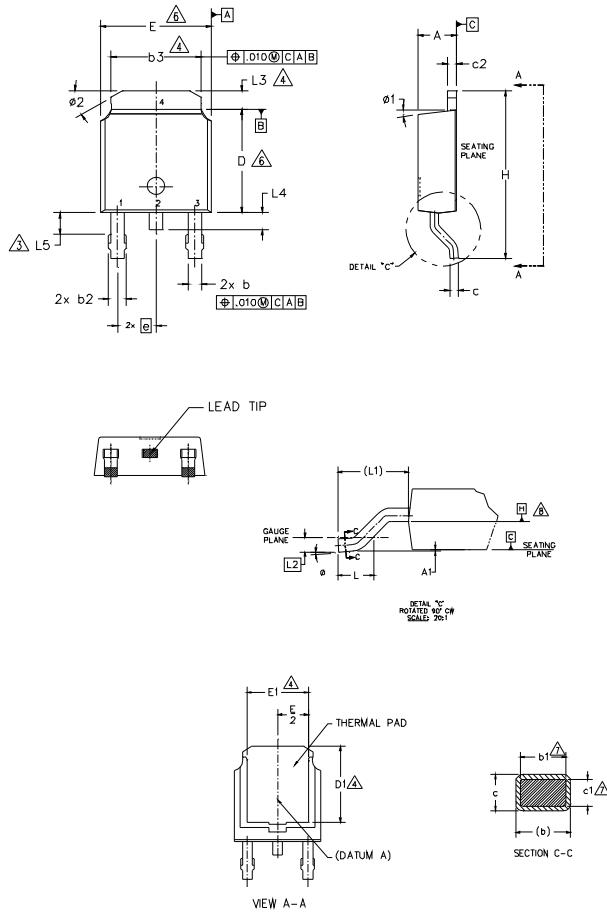


**Fig 24a.** Gate Charge Test Circuit

**Fig 24b.** Gate Charge Waveform

## D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



## NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- △ - LEAD DIMENSION UNCONTROLLED IN L5.
- △ - DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- △ - DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- △ - DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- △ - DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	2.18	2.39	.086	.094		
A1	—	0.13	—	.005		
b	0.64	0.89	.025	.035		
b1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
c	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	—	.205	—	4	
E	6.35	6.73	.250	.265	6	
E1	4.32	—	.170	—	4	
e	2.29 BSC	—	.090 BSC	—		
H	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74 BSC	—	.108 REF.	—		
L2	0.51 BSC	—	.020 BSC	—		
L3	0.89	1.27	.035	.050	4	
L4	—	1.02	—	.040		
L5	1.14	1.52	.045	.060	3	
Ø	0°	10°	0°	10°		
Ø1	0°	15°	0°	15°		
Ø2	25°	35°	25°	35°		

LEAD ASSIGNMENTSHEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

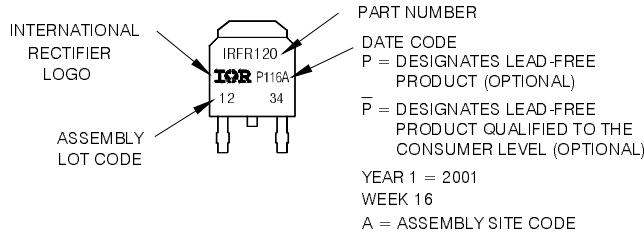
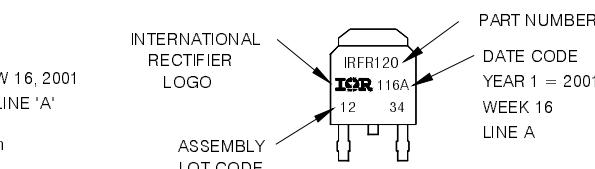
- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

## D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120  
WITH ASSEMBLY  
LOT CODE 1234  
ASSEMBLED ON WW 16, 2001  
IN THE ASSEMBLY LINE 'A'

Note: 'P' in assembly line position  
indicates 'Lead-Free'

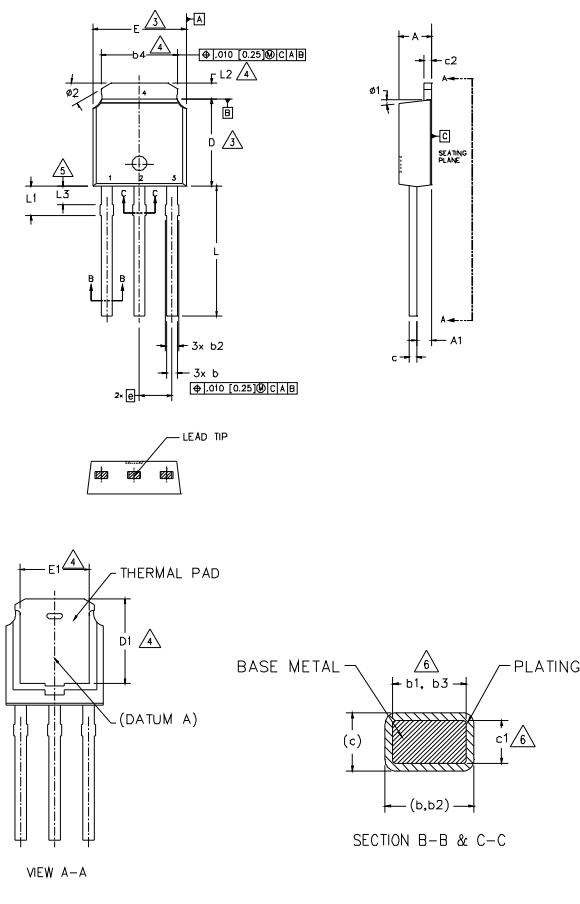
'P' in assembly line position indicates  
'Lead-Free' qualification to the consumer-level

OR

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3.- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4.- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
- 5.- LEAD DIMENSION UNCONTROLLED IN L3.
- 6.- DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
- 7.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA (Date 06/02).
- 8.- CONTROLLING DIMENSION : INCHES.

SYMBOL	DIMENSIONS			NOTES
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	.086	.094
A1	0.89	1.14	.035	.045
b	0.64	0.89	.025	.035
b1	0.65	0.79	.025	.031
b2	0.76	1.14	.030	.045
b3	0.76	1.04	.030	.041
b4	4.95	5.46	.195	.215
c	0.46	0.61	.018	.024
c1	0.41	0.56	.016	.022
c2	0.46	0.89	.018	.035
D	5.97	6.22	.235	.245
D1	5.21	—	.205	—
E	6.35	6.73	.250	.265
E1	4.32	—	.170	—
e	2.29	BSC	.090	BSC
L	8.89	9.65	.350	.380
L1	1.91	2.29	.045	.090
L2	0.89	1.27	.035	.050
L3	1.14	1.52	.045	.060
ø1	0°	15°	0°	15°
ø2	25°	35°	25°	35°

### LEAD ASSIGNMENTS

#### HEXFET

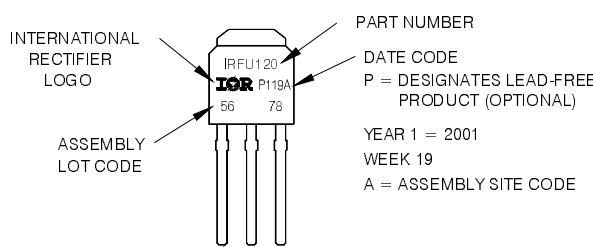
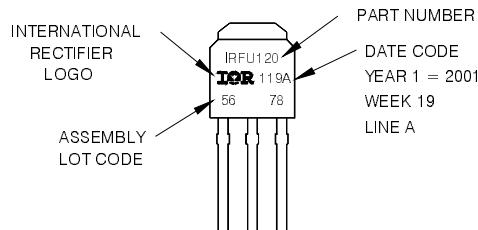
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

## I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120  
WITH ASSEMBLY  
LOT CODE 5678  
ASSEMBLED ON WW 19, 2001  
IN THE ASSEMBLY LINE 'A'

Note: 'P' in assembly line position  
indicates Lead-Free'

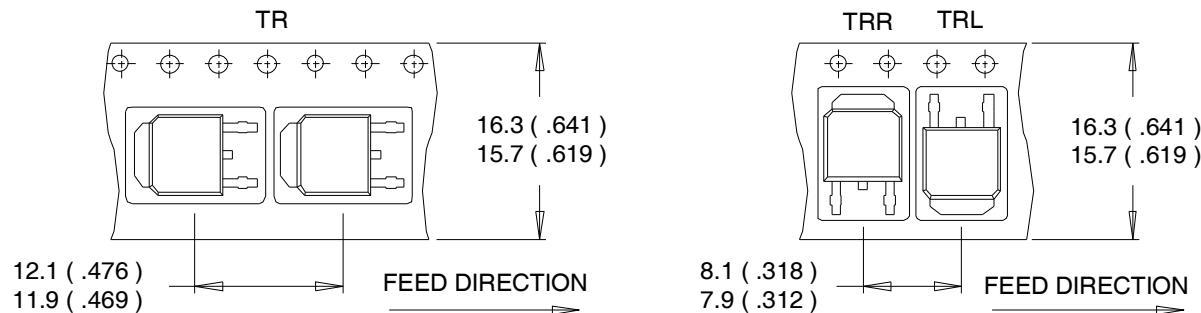
OR



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>  
[www.irf.com](http://www.irf.com)

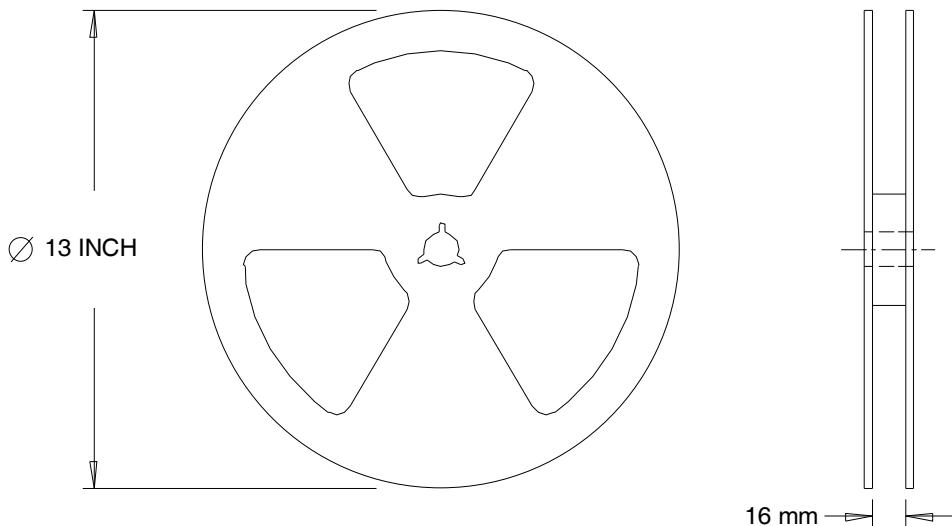
## D-Pak (TO-252AA) Tape &amp; Reel Information

Dimensions are shown in millimeters (inches)



## NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



## NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Orderable part number	Package Type	Standard Pack		Note
		Form	Quantity	
IRFR4510PbF	D-PAK	Tube/Bulk	75	
IRFR4510TRPbF	D-PAK	Tape and Reel	2000	
IRFU4510PbF	I-PAK	Tube/Bulk	75	

### Qualification Information<sup>†</sup>

Qualification level	Industrial <sup>++</sup>	
	(per JEDEC JESD47F <sup>+++</sup> guidelines)	
	Comments: This family of products has passed JEDEC's Industrial qualification. IR's Consumer qualification level is granted by extension of the higher Industrial level.	
Moisture Sensitivity Level	D-PAK	MSL <sup>1</sup>
	I-PAK	(per JEDEC J-STD-020D <sup>+++</sup> ) Not applicable
RoHS Compliant	Yes	

<sup>†</sup> Qualification standards can be found at International Rectifier's web site <http://www.irf.com/product-info/reliability>

<sup>++</sup> Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: <http://www.irf.com/whoto-call/salesrep/>

<sup>+++</sup> Applicable version of JEDEC standard at the time of product release.

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ C$ ,  $L = 0.18mH$   
 $R_G = 50\Omega$ ,  $I_{AS} = 38A$ ,  $V_{GS} = 10V$ . Part not recommended for use above this value.
- ③  $I_{SD} \leq 38A$ ,  $di/dt \leq 2031A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ C$ .
- ④ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .

- ⑤  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥  $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ⑧  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ C$ .

Data and specifications subject to change without notice

International  
**IR** Rectifier

IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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